

# AOD442/AOI442

# 60V N-Channel MOSFET

## **General Description**

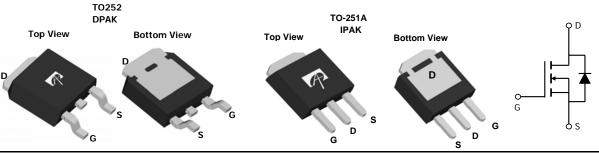
The AOD442/AOI442 used advanced trench technology to provide excellent  $R_{\text{DS(ON)}}$  and low gate charge. Those devices are suitable for use as a load switch or in PWM applications.

## **Product Summary**

 $\begin{array}{ll} V_{DS} & 60V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 37A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 20m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 4.5V) & < 25m\Omega \end{array}$ 

100% UIS Tested 100% R<sub>g</sub> Tested





| Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted |                       |                                   |            |       |  |  |  |  |
|--|-----------------------|-----------------------------------|------------|-------|--|--|--|--|
| Parameter  |                       | Symbol                            | Maximum    | Units |  |  |  |  |
| Drain-Source Voltage   |                       | $V_{DS}$                          | 60         | V     |  |  |  |  |
| Gate-Source Voltage  |                       | $V_{GS}$                          | ±20        | V     |  |  |  |  |
| Continuous Drain   | T <sub>C</sub> =25°C  |                                   | 37         |       |  |  |  |  |
| Current <sup>G</sup>   | T <sub>C</sub> =100°C | 'D                                | 26         | А     |  |  |  |  |
| Pulsed Drain Current <sup>C</sup>                                    |                       | I <sub>DM</sub>                   | 60         |       |  |  |  |  |
| Continuous Drain   | T <sub>A</sub> =25°C  |                                   | 7          | А     |  |  |  |  |
| Current  | T <sub>A</sub> =70°C  | IDSM                              | 5          | A     |  |  |  |  |
| Avalanche Current <sup>C</sup>                                       |                       | I <sub>AS</sub> , I <sub>AR</sub> | 30         | А     |  |  |  |  |
| Avalanche energy L=0.1mH <sup>C</sup>                                |                       | E <sub>AS</sub> , E <sub>AR</sub> | 45         | mJ    |  |  |  |  |
|  | T <sub>C</sub> =25°C  | D                                 | 60         | W     |  |  |  |  |
| Power Dissipation <sup>B</sup>                                       | T <sub>C</sub> =100°C | P <sub>D</sub>                    | 30         | VV    |  |  |  |  |
|  | T <sub>A</sub> =25°C  | Р                                 | 2.1        | W     |  |  |  |  |
| Power Dissipation A  | T <sub>A</sub> =70°C  | P <sub>DSM</sub>                  | 1.3        | VV    |  |  |  |  |
| Junction and Storage Temperature Range                               |                       | $T_J, T_{STG}$                    | -55 to 175 | °C    |  |  |  |  |

| Thermal Characteristics        |              |                                   |      |     |       |  |  |  |  |
|--------------------------------|--------------|-----------------------------------|------|-----|-------|--|--|--|--|
| Parameter                      |              | Symbol                            | Тур  | Max | Units |  |  |  |  |
| Maximum Junction-to-Ambient A  | t ≤ 10s      | $R_{\scriptscriptstyle{	hetaJA}}$ | 17.4 | 25  | °C/W  |  |  |  |  |
| Maximum Junction-to-Ambient AD | Steady-State | ТЧДА                              | 51   | 60  | °C/W  |  |  |  |  |
| Maximum Junction-to-Case       | Steady-State | $R_{\theta JC}$                   | 1.8  | 2.5 | °C/W  |  |  |  |  |



## Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                | Parameter                           | Conditions  | Min  | Тур  | Max  | Units |  |  |  |  |
|-----------------------|-------------------------------------|---|------|------|------|-------|--|--|--|--|
| STATIC PARAMETERS     |                                     |   |      |      |      |       |  |  |  |  |
| BV <sub>DSS</sub>     | Drain-Source Breakdown Voltage      | $I_D = 250 \mu A, V_{GS} = 0 V$                                 | 60   |      |      | V     |  |  |  |  |
| I <sub>DSS</sub>      | Zero Gate Voltage Drain Current     | V <sub>DS</sub> =48V, V <sub>GS</sub> =0V                       |      |      | 1    | μΑ    |  |  |  |  |
|                       | Zero Gate Voltage Brain Garrent     | T <sub>J</sub> =55°(  |      |      | 5    |       |  |  |  |  |
| $I_{GSS}$             | Gate-Body leakage current           | $V_{DS}$ =0V, $V_{GS}$ = ±20V                                   |      |      | 100  | nA    |  |  |  |  |
| $V_{GS(th)}$          | Gate Threshold Voltage              | $V_{DS}=V_{GS} I_{D}=250\mu A$                                  | 1.6  | 2.1  | 2.7  | >     |  |  |  |  |
| $I_{D(ON)}$           | On state drain current              | $V_{GS}$ =10V, $V_{DS}$ =5V                                     | 60   |      |      | Α     |  |  |  |  |
| R <sub>DS(ON)</sub>   | Static Drain-Source On-Resistance   | V <sub>GS</sub> =10V, I <sub>D</sub> =20A                       |      | 16   | 20   | mΩ    |  |  |  |  |
|                       |                                     | T <sub>J</sub> =125°0   |      | 31   | 37   | 11122 |  |  |  |  |
|                       |                                     | $V_{GS}$ =4.5V, $I_D$ =20A                                      |      | 20   | 25   | mΩ    |  |  |  |  |
| g <sub>FS</sub>       | Forward Transconductance            | $V_{DS}$ =5V, $I_D$ =20A  |      | 65   |      | S     |  |  |  |  |
| $V_{SD}$              | Diode Forward Voltage               | I <sub>S</sub> =1A,V <sub>GS</sub> =0V                          |      | 0.7  | 1    | V     |  |  |  |  |
| I <sub>S</sub>        | Maximum Body-Diode Continuous Curre |   |      | 32   | Α    |       |  |  |  |  |
| DYNAMIC               | PARAMETERS                          |   |      |      |      |       |  |  |  |  |
| C <sub>iss</sub>      | Input Capacitance                   |   | 1535 | 1920 | 2300 | pF    |  |  |  |  |
| C <sub>oss</sub>      | Output Capacitance                  | $V_{GS}$ =0V, $V_{DS}$ =30V, f=1MHz                             | 108  | 155  | 200  | pF    |  |  |  |  |
| $C_{rss}$             | Reverse Transfer Capacitance        |   | 70   | 116  | 165  | pF    |  |  |  |  |
| $R_g$                 | Gate resistance                     | $V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz                              | 0.3  | 0.65 | 0.8  | Ω     |  |  |  |  |
| SWITCHIN              | NG PARAMETERS                       |   |      |      |      |       |  |  |  |  |
| Q <sub>g</sub> (10V)  | Total Gate Charge                   |   | 38   | 47.6 | 68   | nC    |  |  |  |  |
| Q <sub>g</sub> (4.5V) | Total Gate Charge                   | V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, I <sub>D</sub> =20A | 20   | 24.2 | 30   | nC    |  |  |  |  |
| $Q_{gs}$              | Gate Source Charge                  | V <sub>GS</sub> -10V, V <sub>DS</sub> -30V, I <sub>D</sub> -20A | 4.8  | 6    | 7    | nC    |  |  |  |  |
| $Q_{gd}$              | Gate Drain Charge                   | 1   | 8.5  | 14.4 | 20   | nC    |  |  |  |  |
| $t_{D(on)}$           | Turn-On DelayTime                   |   |      | 7.4  |      | ns    |  |  |  |  |
| t <sub>r</sub>        | Turn-On Rise Time                   | $V_{GS}$ =10V, $V_{DS}$ =30V, $R_L$ =1.5 $\Omega$ ,             |      | 5.1  |      | ns    |  |  |  |  |
| $t_{D(off)}$          | Turn-Off DelayTime                  | $R_{GEN}$ =3 $\Omega$   |      | 28.2 |      | ns    |  |  |  |  |
| t <sub>f</sub>        | Turn-Off Fall Time                  |   |      | 5.5  |      | ns    |  |  |  |  |
| t <sub>rr</sub>       | Body Diode Reverse Recovery Time    | I <sub>F</sub> =20A, dI/dt=100A/μs                              |      | 34   | 41   | ns    |  |  |  |  |
| Q <sub>rr</sub>       | Body Diode Reverse Recovery Charge  | I <sub>F</sub> =20A, dI/dt=100A/μs                              |      | 46   |      | nC    |  |  |  |  |

A. The value of  $R_{0JA}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25°C. The Power dissipation  $P_{DSM}$  is based on R  $_{0JA}$  and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

- D. The  $R_{\theta JA}$  is the sum of the thermal impedence from junction to case  $R_{\theta JC}$  and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =175°C. The SOA curve provides a single pulse rating.
- G. The maximum current rating is package limited.
- H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =175°C. Ratings are based on low frequency and duty cycles to keep initial  $T_J$ =25°C.



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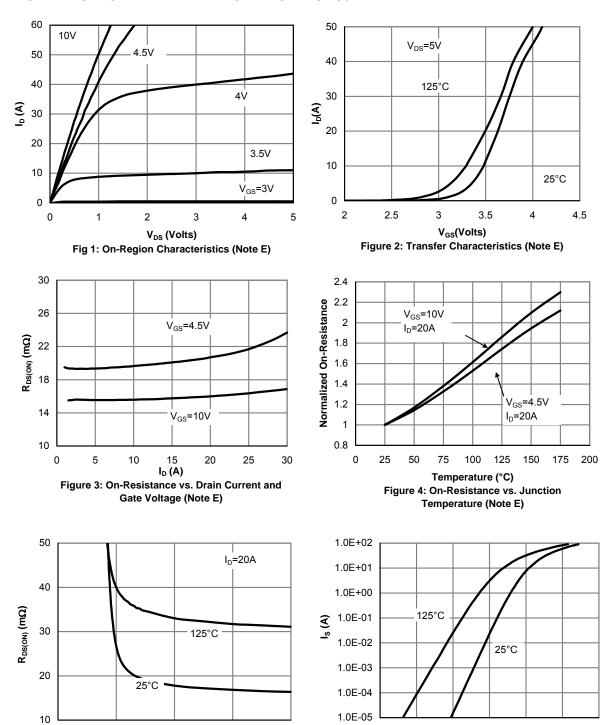
6

V<sub>GS</sub> (Volts)

Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

8

#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



10

0.0

0.2

0.4

0.6

V<sub>SD</sub> (Volts)

Figure 6: Body-Diode Characteristics (Note E)

0.8

1.0

1.2



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

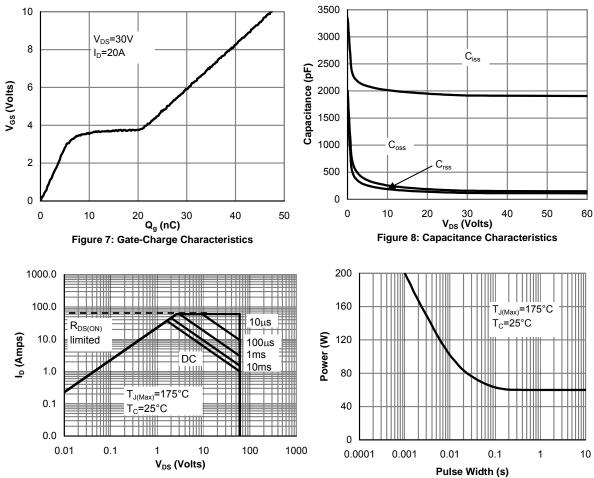


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

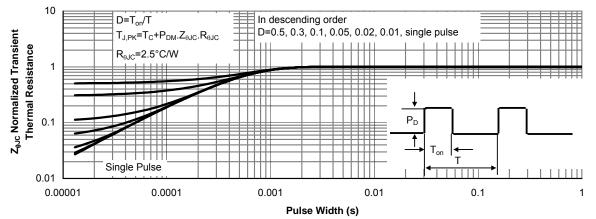
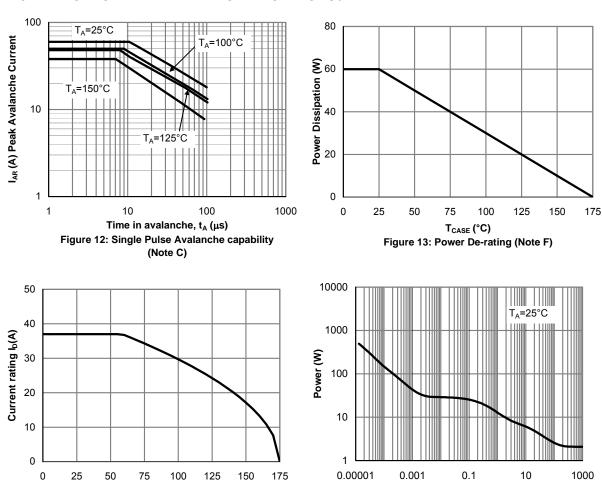


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



T<sub>CASE</sub> (°C)
Figure 14: Current De-rating (Note F)

Pulse Width (s)
Figure 15: Single Pulse Power Rating Junction-toAmbient (Note H)

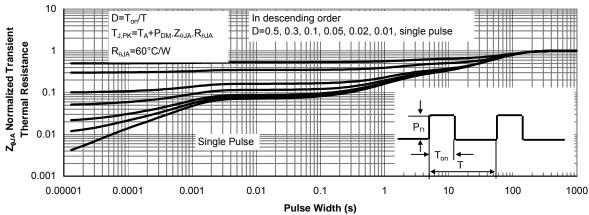
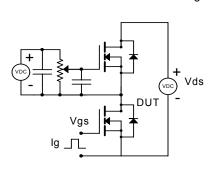
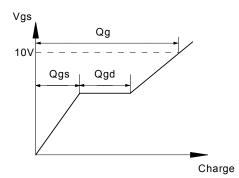


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

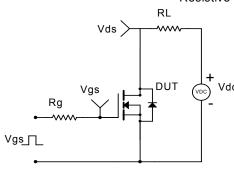


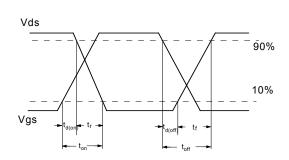
## Gate Charge Test Circuit & Waveform



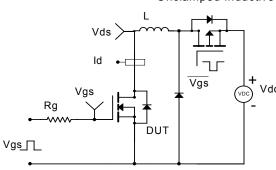


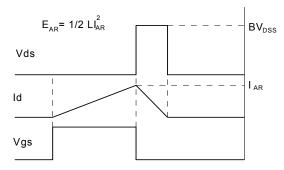
Resistive Switching Test Circuit & Waveforms





# Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





# Diode Recovery Test Circuit & Waveforms

